

Search Notes

Application/Control No.

09/836,397

Examiner

Sargon N. Nano

Applicant(s)/Patent under
Reexamination

CHAN, HARK C.

Art Unit

2157

SEARCHED

Class	Subclass	Date	Examiner
709	218 , 219 227 , 228	12/2/2005	SN

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST (see report)	12/2/2005	SN